

Switching

TOSHIBA Power Transistor Module Silicon NPN&PNP Epitaxial Type (Four Darlington Power Transistors in One)

MP4005

High Power Switching Applications
Hammer Drive, Pulse Motor Drive and Inductive Load

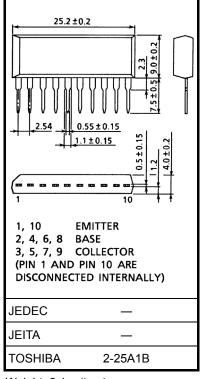
- Small package by full molding (SIP 10 pins)
- High collector power dissipation (4-device operation)
 PT = 4 W (Ta = 25°C)
- High collector current: $IC(DC) = \pm 4 A (max)$
- High DC current gain: $h_{FE} = 2000$ (min) ($V_{CE} = \pm 2$ V, $I_{C} = \pm 1$ A)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating		Unit	
		Symbol	NPN	PNP	Offic	
Collector-base voltage		V _{CBO}	100	-100	٧	
Collector-emitter voltage		V _{CEO}	80	-80	V	
Emitter-base voltage		V _{EBO}	5	-5	V	
Collector current	DC	IC	4	-4	А	
	Pulse	I _{CP}	6	-6		
Continuous base current		ΙΒ	0.4	-0.4	Α	
Collector power dissipation		PC	2.0		W	
(1-device operation)	vice operation)				VV	
Collector power dissipation		PT	4.0		W	
(4-device operation)					v v	
Junction temperature		Tj	150		°C	
Storage temperature range		T _{stg}	−55 to 150		°C	

Industrial Applications

Unit: mm



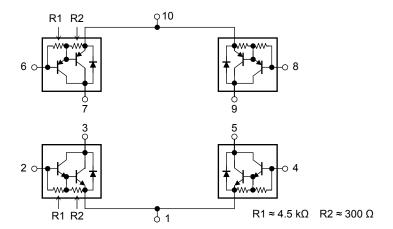
Weight: 2.1 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Array Configuration



Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance from junction to ambient	ΣR _{th (j-a)}	31.3	°C/W
(4-device operation, Ta = 25°C)			
Maximum lead temperature for soldering purposes	TL	260	°C
(3.2 mm from case for 10 s)			

Electrical Characteristics (Ta = 25°C) (NPN transistor)

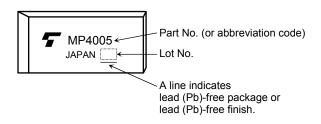
Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off cu	rrent	I _{CBO}	V _{CB} = 100 V, I _E = 0 A	20		μA	
Collector cut-off cu	rrent	I _{CEO}	V _{CE} = 80 V, I _B = 0 A	_	_	_ 20	
Emitter cut-off curr	ent	I _{EBO}	V _{EB} = 5 V, I _C = 0 A	0.5	_	2.5	mA
Collector-base brea	akdown voltage	V (BR) CBO	I _C = 1 mA, I _E = 0 A	100	_	_	V
Collector-emitter bi	reakdown voltage	V (BR) CEO	I _C = 10 mA, I _B = 0 A	80	_	_	V
DC current gain		h _{FE (1)}	V _{CE} = 2 V, I _C = 1 A	2000	_	_	
		h _{FE (2)}	V _{CE} = 2 V, I _C = 3 A	1000	_	_	_
Saturation voltage	Collector-emitter	V _{CE} (sat)	I _C = 3 A, I _B = 6 mA	_	_	1.5	V
	Base-emitter	V _{BE} (sat)	I _C = 3 A, I _B = 6 mA	_	_	2.0	
Transition frequence	cy	f _T	V _{CE} = 2 V, I _C = 0.5 A	_	60	_	MHz
Collector output ca	pacitance	C _{ob}	V _{CB} = 10 V, I _E = 0 A, f = 1 MHz	_	_ 30 _		pF
Switching time Storage	Turn-on time	t _{on}	Output Input B1 C C C C V C V C S V C S V C S V C S V C S V C S S V C S S S S S S S S S S S S	_	0.2	_	
	Storage time	t _{stg}		_	1.5	_	μs
	Fall time	t _f	<u>V </u>	_	0.6	_	



Electrical Characteristics (Ta = 25°C) (PNP transistor)

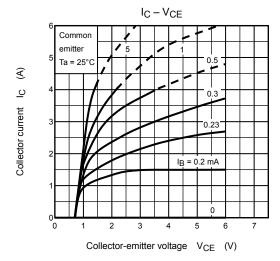
Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Collector cut-off cu	rrent	I _{CBO}	V _{CB} = -100 V, I _E = 0 A	_	_	-20	μΑ	
Collector cut-off cu	rrent	I _{CEO}	V _{CE} = -80 V, I _B = 0 A	_	_	-20	μΑ	
Emitter cut-off curre	ent	I _{EBO}	V _{EB} = -5 V, I _C = 0 A	-0.5	_	-2.5	mA	
Collector-base brea	akdown voltage	V (BR) CBO	I _C = -1 mA, I _E = 0 A	-100	_	_	V	
Collector-emitter bi	reakdown voltage	V (BR) CEO	I _C = -10 mA, I _B = 0 A	-80	_	_	V	
DC aurrent gain		h _{FE (1)}	V _{CE} = -2 V, I _C = -1 A	2000	_	_		
DC current gain		h _{FE (2)}	V _{CE} = -2 V, I _C = -3 A	1000	_	_	_	
Saturation voltage	Collector-emitter	V _{CE} (sat)	I _C = -3 A, I _B = -6 mA	_	_	-1.5	V	
	Base-emitter	V _{BE} (sat)	I _C = -3 A, I _B = -6 mA	_	_	-2.0		
Transition frequence	cy	f _T	V _{CE} = -2 V, I _C = -0.5 A	_	40	_	MHz	
Collector output ca	pacitance	C _{ob}	V _{CB} = -10 V, I _E = 0 A, f = 1 MHz	_ 55 <u></u>		_	pF	
Switching time	Turn-on time	t _{on}	Output Input B2 Output 20 µs IB1	_	0.15	_		
	Storage time	t _{stg}			0.80		μs	
	Fall time	t _f	V_{CC} = -30 V $-I_{B1}$ = I_{B2} = 6 mA, duty cycle \leq 1%	_	0.40	_		

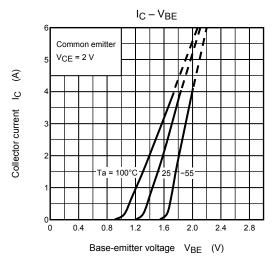
Marking

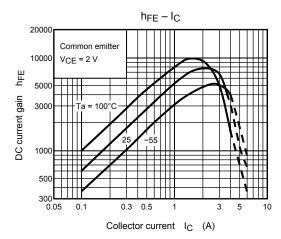


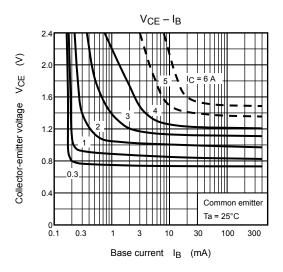


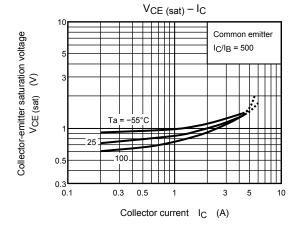
(NPN transistor)

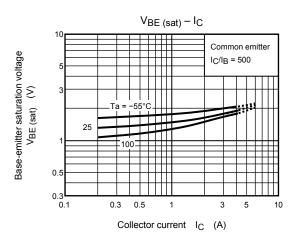






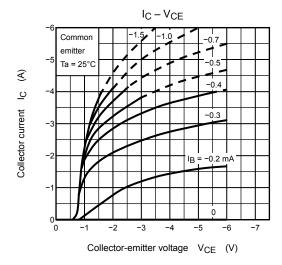


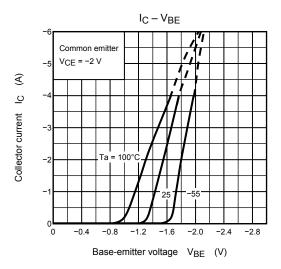


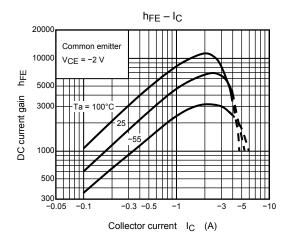


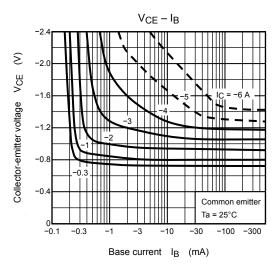


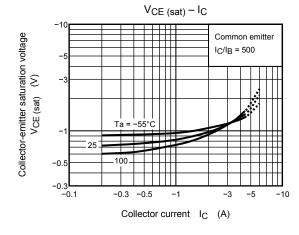
(PNP transistor)

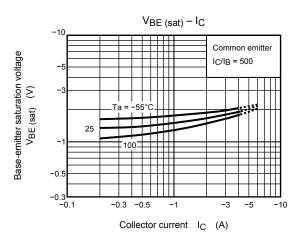


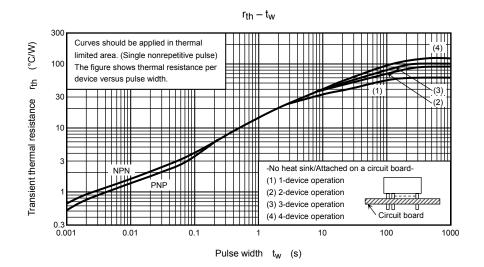


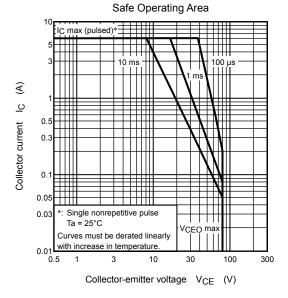


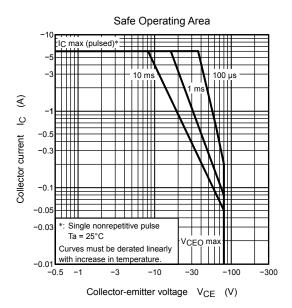


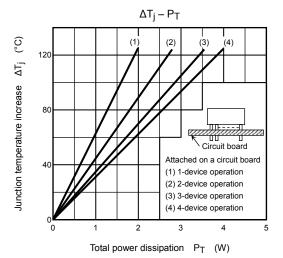


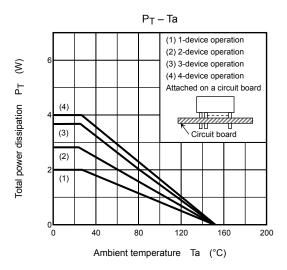


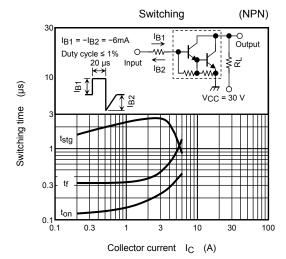


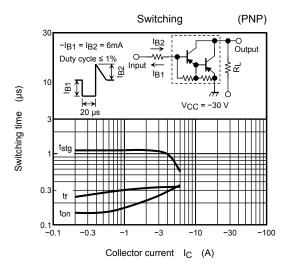












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